

# MOSFET - Power, Single N-Channel

80 V, 1.5 mΩ, 255 A

# NTMTS1D5N08H

#### **Features**

- Small Footprint (8x8 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	80	V
Gate-to-Source Voltage	Э		$V_{GS}$	±20	٧
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	255	Α
Current R <sub>0JC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		162	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	208	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		83	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	36	Α
Current R <sub>0JA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		23	
Power Dissipation	State	T <sub>A</sub> = 25°C	$P_{D}$	4.2	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.7	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	173	Α
Single Pulse Drain-to-Source Avalanche Energy (L = 3 mH, I <sub>L(pk)</sub> = 32 A)			E <sub>AS</sub>	1536	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

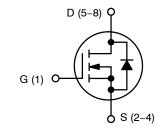
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

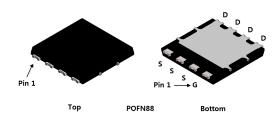
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	1.5 mΩ @ 10 V	255 A



**N-CHANNEL MOSFET** 



DFNW8 CASE 507AP

#### **MARKING DIAGRAM**



A = Assembly Location
WL = 2-digit Wafer Lot Code

Y = Year Code WW = Work Week Code

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit	
OFF CHARACTERISTICS	Cyllibol	iest condi		"""	٩٧٠	max	l oim	
Drain-to-Source Breakdown Voltage	V	\\\\\\\	2504	80	1		V	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$		80	59		V	
Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				39		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			10		
		$V_{DS} = 80 \text{ V}$	T <sub>J</sub> = 125°C			250	μΑ	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	s = 20 V			100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 490 μΑ	2.0	3.0	4.0	V	
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-6.9		mV/°C	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 90 A		1.16	1.5	0	
		V <sub>GS</sub> = 6 V	I <sub>D</sub> = 49 A		1.68	2.0	mΩ	
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D}$	= 90 A		294		S	
CHARGES, CAPACITANCES & GATE RESI	STANCE							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 40 V			8220			
Output Capacitance	C <sub>OSS</sub>				1190		pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>				31			
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 64 V; I <sub>D</sub> = 90 A			125		nC	
Threshold Gate Charge	Q <sub>G(TH)</sub>				21			
Gate-to-Source Charge	$Q_{GS}$				34			
Gate-to-Drain Charge	$Q_{GD}$				29			
Plateau Voltage	$V_{GP}$				4.5		V	
SWITCHING CHARACTERISTICS (Note 5)								
Turn-On Delay Time	t <sub>d(ON)</sub>				33			
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 64 V, $I_{D}$ = 90 A, $R_{G}$ = 6 $\Omega$			23		ns	
Turn-Off Delay Time	t <sub>d(OFF)</sub>				100			
Fall Time	t <sub>f</sub>				30			
DRAIN-SOURCE DIODE CHARACTERISTI	cs							
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 90 A	T <sub>J</sub> = 25°C		0.8	1.2	V	
		$I_S = 90 \text{ A}$	T <sub>J</sub> = 125°C		0.7		]	
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt}$	= 100 A/μs,		75		ns	
Reverse Recovery Charge	$Q_{RR}$	$I_S = 90 A$			146		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

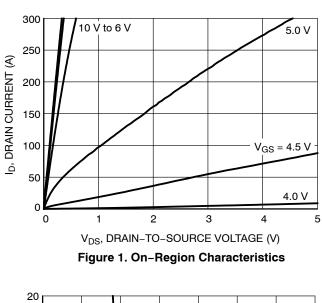
4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

300

250



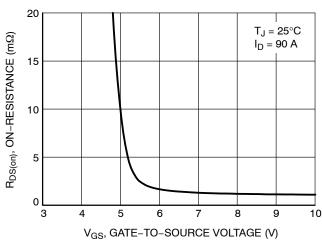
T<sub>J</sub> = 25°C

T<sub>J</sub> = 25°C

T<sub>J</sub> = 55°C

T<sub>J</sub> = -55°C

V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics



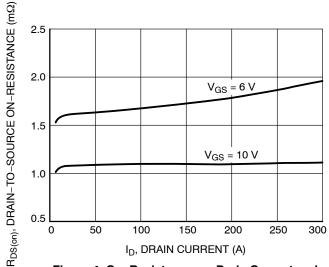
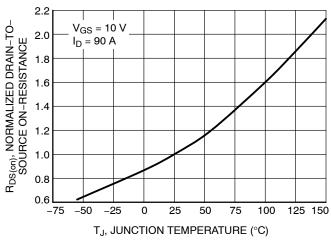


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



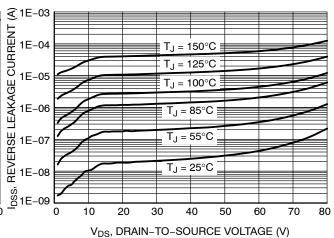


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

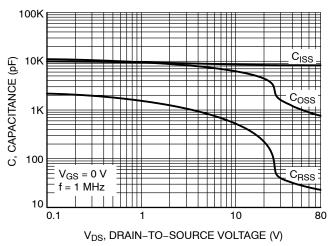


Figure 7. Capacitance Variation

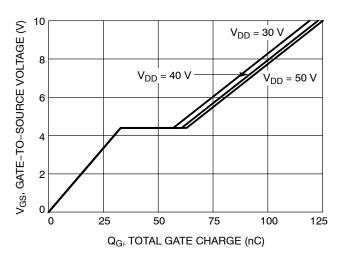


Figure 8. Gate-to-Source Voltage vs. Total Charge

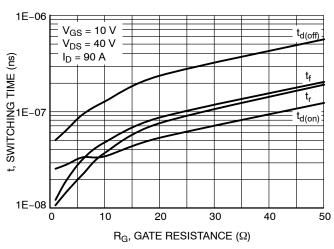


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

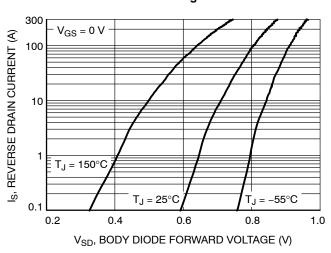


Figure 10. Diode Forward Voltage vs. Current

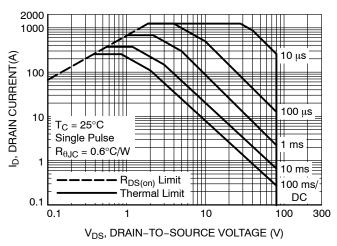


Figure 11. Maximum Rated Forward Biased Safe Operating Area

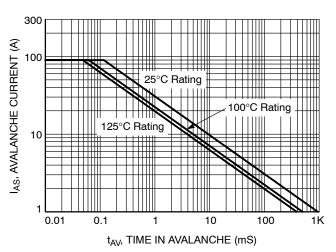


Figure 12. Maximum Drain Current vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

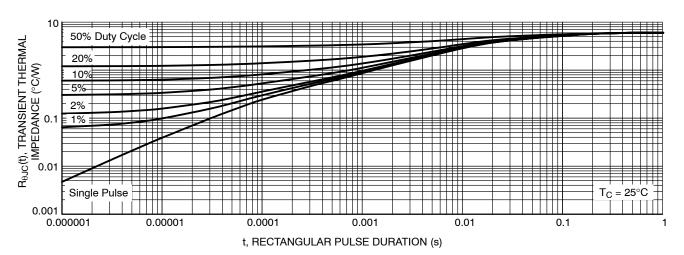


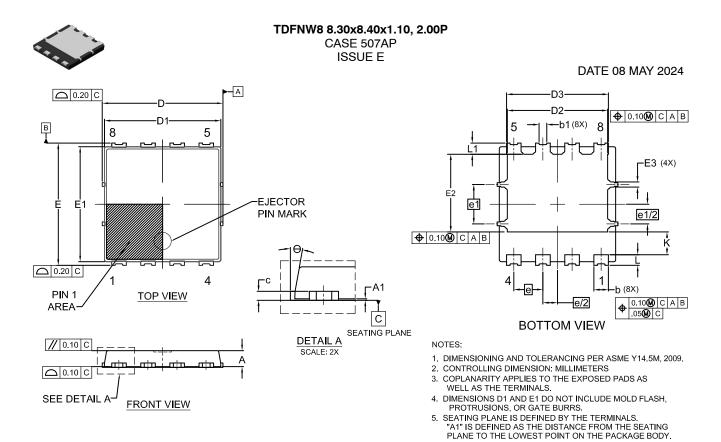
Figure 13. Thermal Response

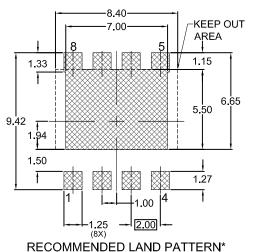
#### **DEVICE ORDERING INFORMATION**

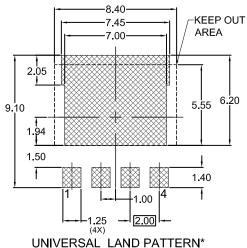
Device	Marking	Package	Shipping <sup>†</sup>
NTMTS1D5N08H	NTMTS1D5N08H	POWER 88 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.









DIM	N	IILLIMET	ERS
Dilvi	MIN.	NOM.	MAX.
Α	1.00	1.10	1.20
A1	0.00	-	0.05
b	0.90	1.00	1.10
b1	0.35	0.45	0.55
С	0.23	0.28	0.33
D	8.20	8.30	8.40
D1	7.90	8.00	8.10
D2	6.80	6.90	7.00
D3	6.90	7.00	7.10
E	8.30	8.40	8.50
E1	7.80	7.90	8.00
E2	5.24	5.34	5.44
E3	0.25	0.35	0.45
е		2.00 BS	O
e/2	1.00 BSC		
e1	2.70 BSC		
e1/2	1.35 BSC		
K	1.50	1.57	1.70
L	0.64	0.74	0.84
L1	0.67	0.77	0.87
θ	0°		12°

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE
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REFERENCE MANUAL, SOLDERRM/D.

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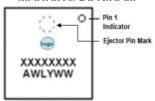


# TDFNW8 8.30x8.40x1.10, 2.00P

CASE 507AP ISSUE E

**DATE 08 MAY 2024** 

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
WW = Work Week Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.

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